

Notice of References Cited

Application/Control No.

09/560,268

Applicant(s)/Patent Under

Reexamination

LEE ET AL.

Examiner

DuyVu n Deo

Art Unit

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,350,564	09-1982	Wei	156/659.1
	B	US-5,945,346	08-1999	Vanell et al.	438/691
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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